

IRF9910PbF

HEXFET® Power MOSFET

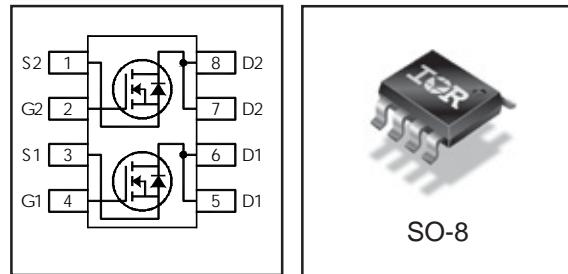
Applications

- Dual SO-8 MOSFET for POL converters in desktop, servers, graphics cards, game consoles and set-top box
- Lead-Free

V_{DSS}	R_{DS(on)} max	I_D
20V	Q1 13.4mΩ@V_{GS} = 10V	10A
	Q2 9.3mΩ@V_{GS} = 10V	12A

Benefits

- Very Low R_{DS(on)} at 4.5V V_{GS}
- Low Gate Charge
- Fully Characterized Avalanche Voltage and Current
- 20V V_{GS} Max. Gate Rating



Absolute Maximum Ratings

	Parameter	Q1 Max.	Q2 Max.	Units
V _{DS}	Drain-to-Source Voltage	20		V
V _{GS}	Gate-to-Source Voltage		± 20	
I _D @ T _A = 25°C	Continuous Drain Current, V _{GS} @ 10V	10	12	
I _D @ T _A = 70°C	Continuous Drain Current, V _{GS} @ 10V	8.3	9.9	A
I _{DM}	Pulsed Drain Current ①	83	98	
P _D @ T _A = 25°C	Power Dissipation	2.0		W
P _D @ T _A = 70°C	Power Dissipation	1.3		
	Linear Derating Factor	0.016		W/°C
T _J	Operating Junction and			°C
T _{STG}	Storage Temperature Range	-55 to +150		

Thermal Resistance

	Parameter	Typ.	Max.	Units
R _{θJL}	Junction-to-Drain Lead	—	20	°C/W
R _{θJA}	Junction-to-Ambient ④⑤	—	62.5	

Notes ① through ⑤ are on page 10

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Static @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter		Min.	Typ.	Max.	Units	Conditions
BV_{DSS}	Drain-to-Source Breakdown Voltage	Q1&Q2	20	—	—	V	$V_{\text{GS}} = 0\text{V}, I_D = 250\mu\text{A}$
$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	Q1	—	0.0061	—	$^\circ\text{C}$	Reference to 25°C , $I_D = 1\text{mA}$
$R_{\text{DS(on)}}$	Static Drain-to-Source On-Resistance	Q1	—	10.7	13.4	$\text{m}\Omega$	$V_{\text{GS}} = 10\text{V}, I_D = 10\text{A}$ ③
		—	—	14.6	18.3		$V_{\text{GS}} = 4.5\text{V}, I_D = 8.3\text{A}$ ③
		Q2	—	7.4	9.3		$V_{\text{GS}} = 10\text{V}, I_D = 12\text{A}$ ③
		—	—	9.1	11.3		$V_{\text{GS}} = 4.5\text{V}, I_D = 9.8\text{A}$ ③
$V_{\text{GS(th)}}$	Gate Threshold Voltage	Q1&Q2	1.65	—	2.55	V	$V_{\text{DS}} = V_{\text{GS}}, I_D = 250\mu\text{A}$
$\Delta V_{\text{GS(th)}}/\Delta T_J$	Gate Threshold Voltage Coefficient	Q1	—	-4.9	—	$\text{mV}/^\circ\text{C}$	$V_{\text{DS}} = 16\text{V}, V_{\text{GS}} = 0\text{V}$
		Q2	—	-5.0	—		$V_{\text{DS}} = 16\text{V}, V_{\text{GS}} = 0\text{V}, T_J = 125^\circ\text{C}$
I_{DSS}	Drain-to-Source Leakage Current	Q1&Q2	—	—	1.0	μA	$V_{\text{DS}} = 16\text{V}, V_{\text{GS}} = 0\text{V}$
	—	Q1&Q2	—	—	100	nA	$V_{\text{GS}} = 20\text{V}$
I_{GSS}	Gate-to-Source Forward Leakage	Q1&Q2	—	—	100	nA	$V_{\text{GS}} = -20\text{V}$
	Gate-to-Source Reverse Leakage	Q1&Q2	—	—	-100	nA	$V_{\text{GS}} = 20\text{V}$
g_{fs}	Forward Transconductance	Q1	19	—	—	S	$V_{\text{DS}} = 10\text{V}, I_D = 8.3\text{A}$
		Q2	27	—	—		$V_{\text{DS}} = 10\text{V}, I_D = 9.8\text{A}$
Q_g	Total Gate Charge	Q1	—	7.4	11	nC	Q1 $V_{\text{DS}} = 10\text{V}$ $V_{\text{GS}} = 4.5\text{V}, I_D = 8.3\text{A}$
	—	Q2	—	15	23		
Q_{qs1}	Pre-V _{th} Gate-to-Source Charge	Q1	—	2.6	—		
	—	Q2	—	4.3	—		
Q_{qs2}	Post-V _{th} Gate-to-Source Charge	Q1	—	0.85	—		
	—	Q2	—	1.4	—		
Q_{qd}	Gate-to-Drain Charge	Q1	—	2.5	—		
	—	Q2	—	5.4	—		
Q_{qodr}	Gate Charge Overdrive	Q1	—	1.5	—		
	—	Q2	—	3.9	—		
Q_{sw}	Switch Charge ($Q_{\text{qs2}} + Q_{\text{qd}}$)	Q1	—	3.4	—		
	—	Q2	—	6.8	—		
Q_{oss}	Output Charge	Q1	—	4.0	—	ns	$V_{\text{DS}} = 10\text{V}, V_{\text{GS}} = 0\text{V}$
	—	Q2	—	8.7	—		
$t_{\text{d(on)}}$	Turn-On Delay Time	Q1	—	6.3	—		Q1 $V_{\text{DD}} = 16\text{V}, V_{\text{GS}} = 4.5\text{V}$ $I_D = 8.3\text{A}$
	—	Q2	—	8.3	—		
t_r	Rise Time	Q1	—	10	—		
	—	Q2	—	14	—		
$t_{\text{d(off)}}$	Turn-Off Delay Time	Q1	—	9.2	—		
	—	Q2	—	15	—		
t_f	Fall Time	Q1	—	4.5	—		
	—	Q2	—	7.5	—		
C_{iss}	Input Capacitance	Q1	—	900	—	pF	$V_{\text{GS}} = 0\text{V}$ $V_{\text{DS}} = 10\text{V}$ $f = 1.0\text{MHz}$
	—	Q2	—	1860	—		
C_{oss}	Output Capacitance	Q1	—	290	—		
	—	Q2	—	600	—		
C_{rss}	Reverse Transfer Capacitance	Q1	—	140	—		
	—	Q2	—	310	—		

Avalanche Characteristics

	Parameter		Typ.	Q1 Max.	Q2 Max.	Units
E_{AS}	Single Pulse Avalanche Energy ②	—	—	33	26	mJ
I_{AR}	Avalanche Current ①	—	—	8.3	9.8	A

Diode Characteristics

	Parameter		Min.	Typ.	Max.	Units	Conditions
I_s	Continuous Source Current (Body Diode)	Q1&Q2	—	—	2.5	A	MOSFET symbol showing the integral reverse p-n junction diode.
I_{SM}	Pulsed Source Current (Body Diode) ①	Q1	—	—	83	A	$T_J = 25^\circ\text{C}, I_s = 8.3\text{A}, V_{\text{GS}} = 0\text{V}$ ③ $T_J = 25^\circ\text{C}, I_s = 9.8\text{A}, V_{\text{GS}} = 0\text{V}$ ③
		Q2	—	—	98	A	
V_{SD}	Diode Forward Voltage	Q1	—	—	1.0	V	$T_J = 25^\circ\text{C}, I_s = 8.3\text{A}, V_{\text{GS}} = 0\text{V}$ ③ $T_J = 25^\circ\text{C}, I_s = 9.8\text{A}, V_{\text{GS}} = 0\text{V}$ ③
		Q2	—	—	1.0	V	
t_{rr}	Reverse Recovery Time	Q1	—	11	17	ns	Q1 $T_J = 25^\circ\text{C}, I_F = 8.3\text{A}, V_{\text{DD}} = 10\text{V}, dI/dt = 100\text{A}/\mu\text{s}$ ③ Q2 $T_J = 25^\circ\text{C}, I_F = 9.8\text{A}, V_{\text{DD}} = 10\text{V}, dI/dt = 100\text{A}/\mu\text{s}$ ③
		Q2	—	16	24		
Q_{rr}	Reverse Recovery Charge	Q1	—	3.1	4.7	nC	Q1 $T_J = 25^\circ\text{C}, I_F = 8.3\text{A}, V_{\text{DD}} = 10\text{V}, dI/dt = 100\text{A}/\mu\text{s}$ ③ Q2 $T_J = 25^\circ\text{C}, I_F = 9.8\text{A}, V_{\text{DD}} = 10\text{V}, dI/dt = 100\text{A}/\mu\text{s}$ ③
		Q2	—	4.9	7.3		

Typical Characteristics

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Q1 - Control FET

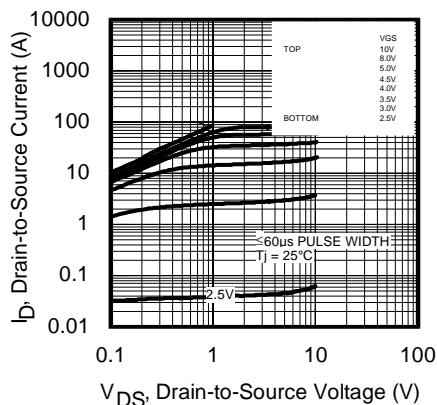


Fig 1. Typical Output Characteristics

Q2 - Synchronous FET

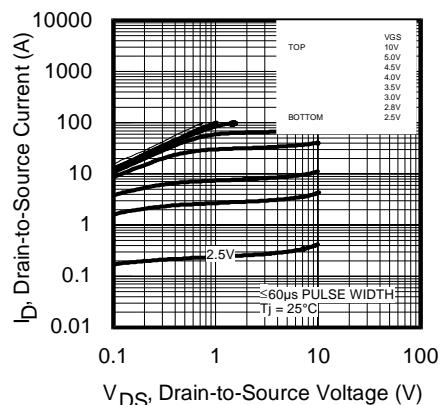


Fig 2. Typical Output Characteristics

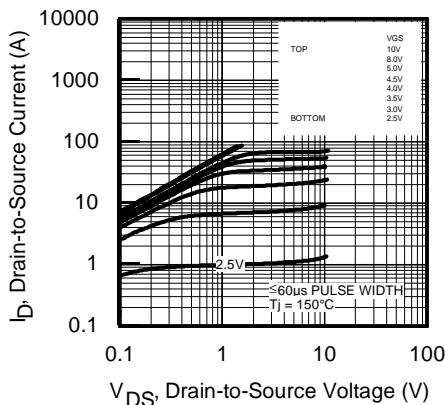


Fig 3. Typical Output Characteristics

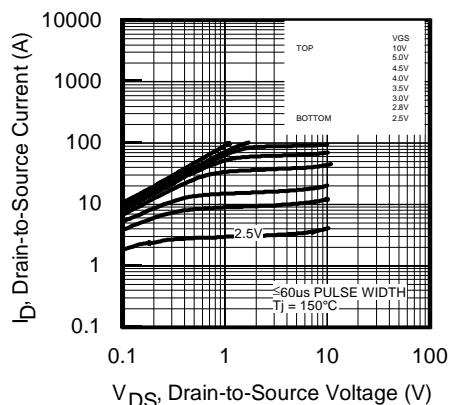


Fig 4. Typical Output Characteristics

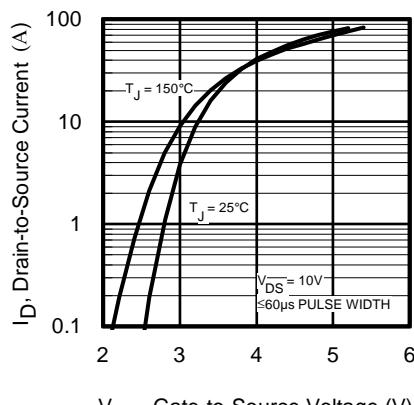


Fig 5. Typical Transfer Characteristics
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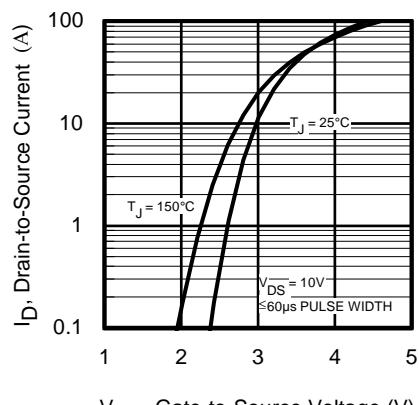


Fig 6. Typical Transfer Characteristics

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Q1 - Control FET

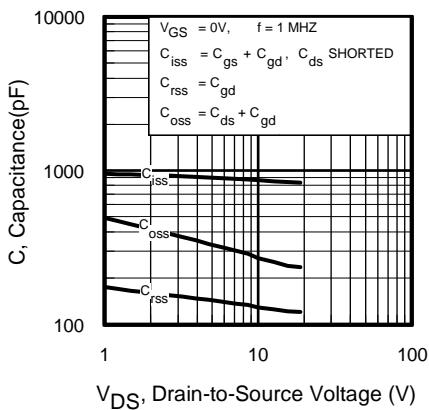


Fig 7. Typical Capacitance Vs.Drain-to-Source Voltage

Q2 - Synchronous FET

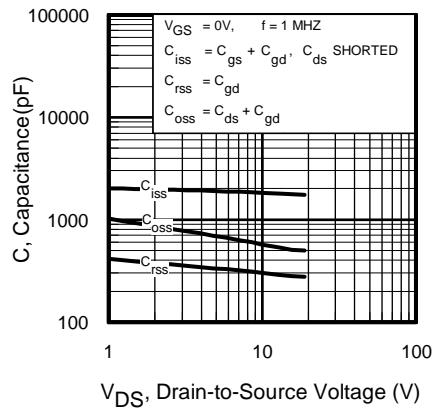


Fig 8. Typical Capacitance Vs.Drain-to-Source Voltage

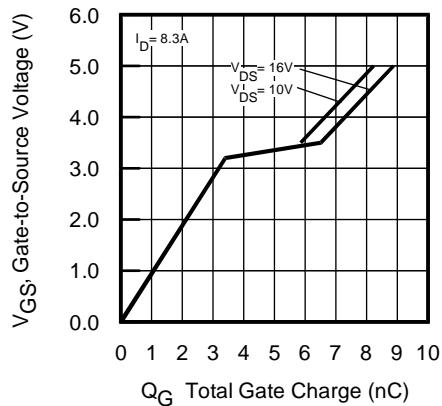


Fig. 9. Gate-to-Source Voltage vs Typical Gate Charge

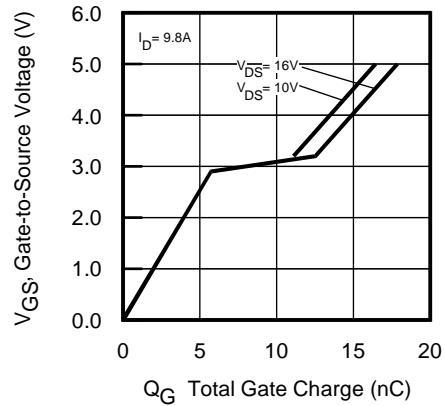


Fig. 10. Gate-to-Source Voltage vs Typical Gate Charge

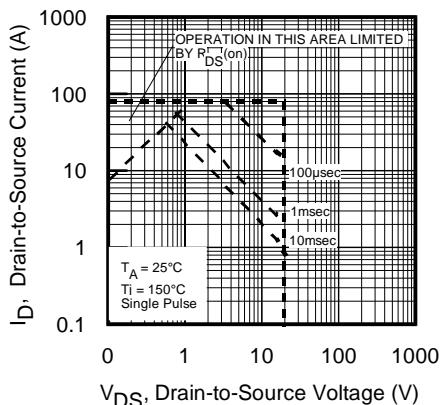


Fig 11. Maximum Safe Operating Area

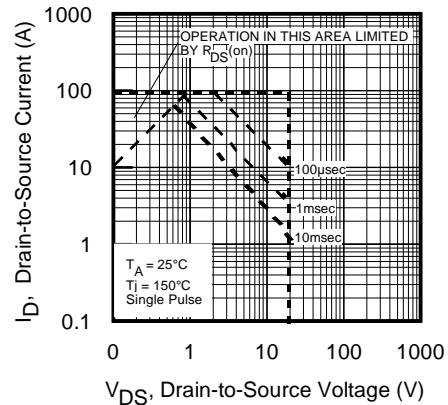


Fig 12. Maximum Safe Operating Area

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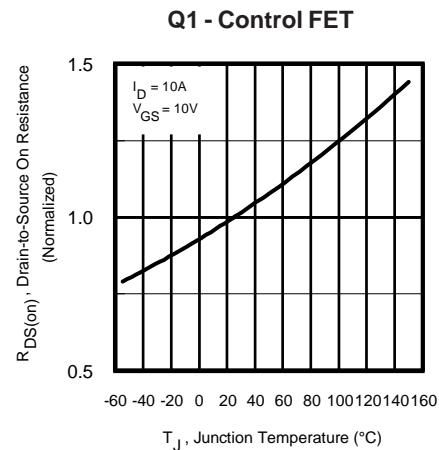


Fig 13. Normalized On-Resistance vs. Temperature

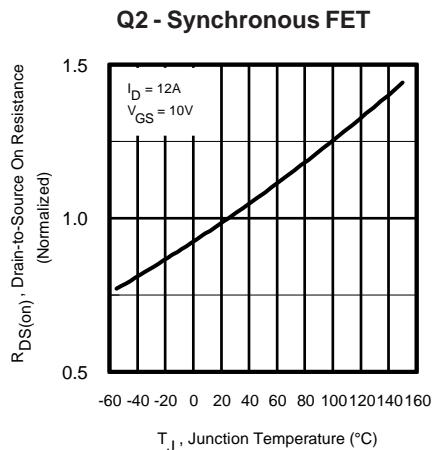


Fig 14. Normalized On-Resistance vs. Temperature

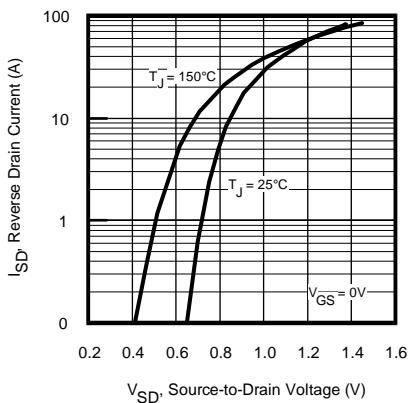


Fig 15. Typical Source-Drain Diode Forward Voltage

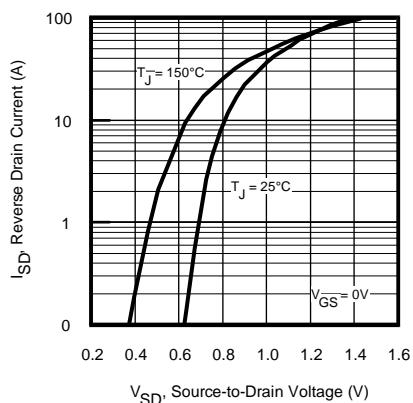


Fig 16. Typical Source-Drain Diode Forward Voltage

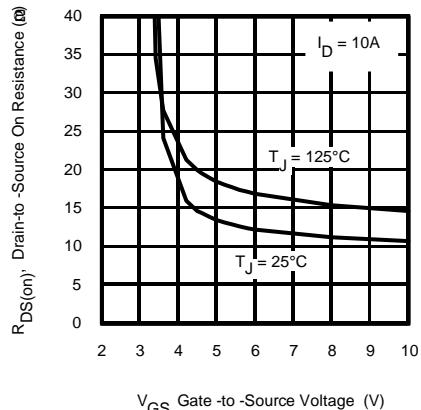


Fig 17. Typical On-Resistance vs. Gate Voltage

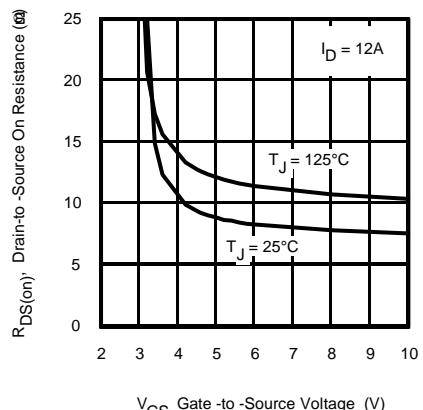


Fig 18. Typical On-Resistance vs. Gate Voltage

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Q1 - Control FET

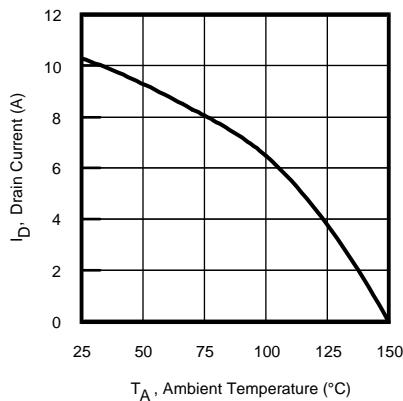


Fig 19. Maximum Drain Current vs. Ambient Temperature

Q2 - Synchronous FET

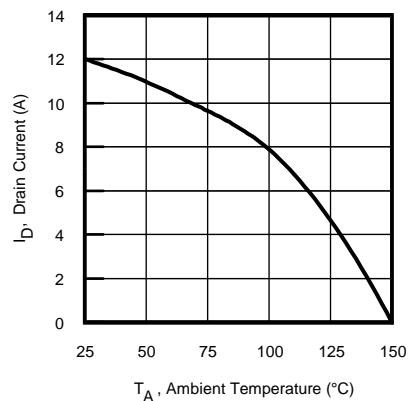


Fig 20. Maximum Drain Current vs. Ambient Temperature

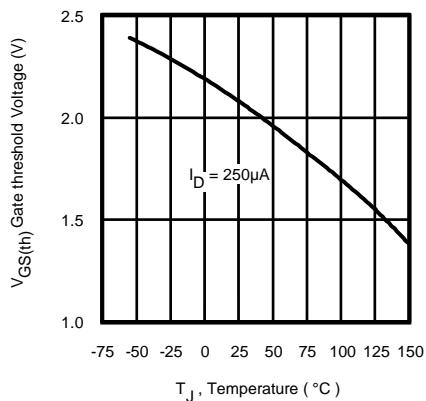


Fig 21. Threshold Voltage vs. Temperature

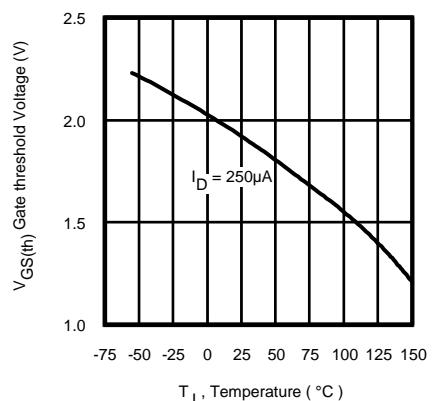


Fig 22. Threshold Voltage vs. Temperature

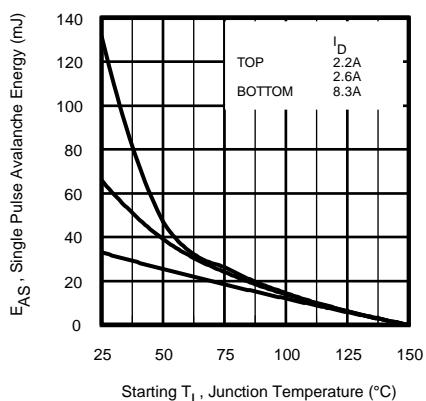


Fig 23. Maximum Avalanche Energy vs. Drain Current

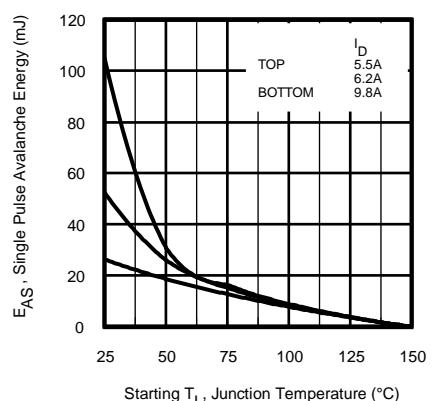


Fig 24. Maximum Avalanche Energy vs. Drain Current

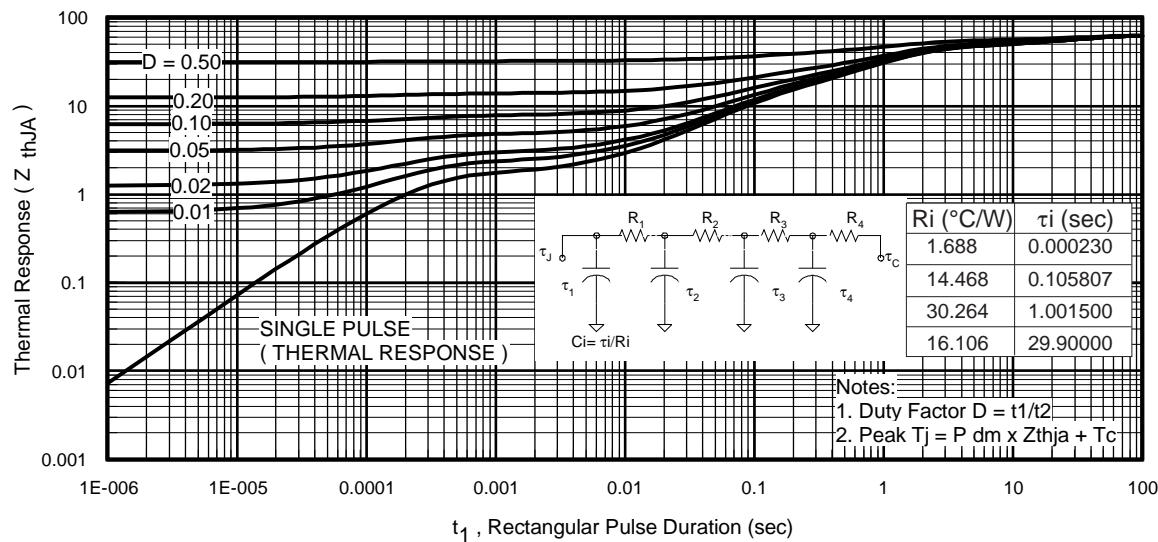


Fig 25. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

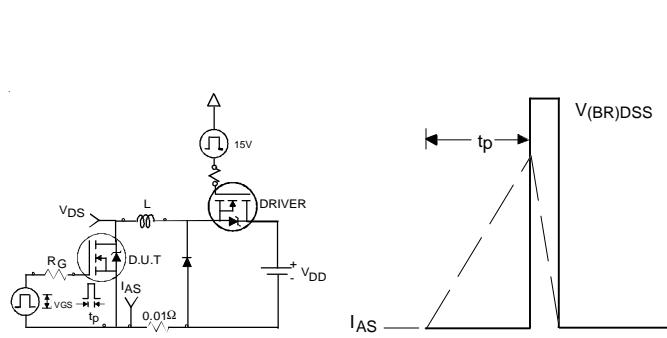


Fig 26. Unclamped Inductive Test Circuit and Waveform

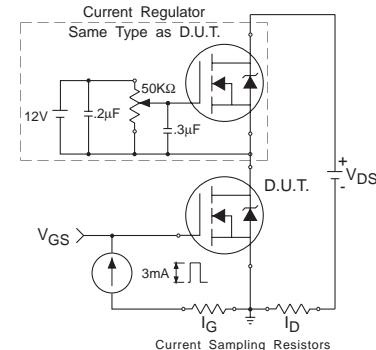


Fig 27. Gate Charge Test Circuit

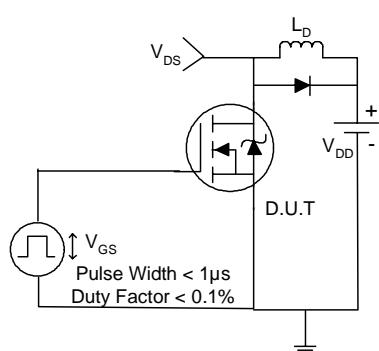


Fig 28. Switching Time Test Circuit
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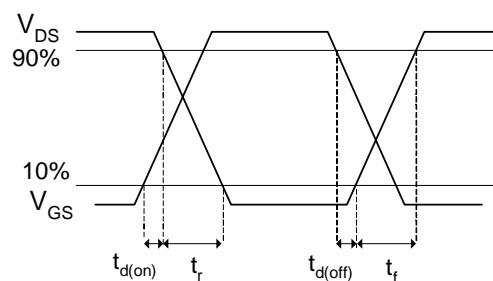


Fig 29. Switching Time Waveforms

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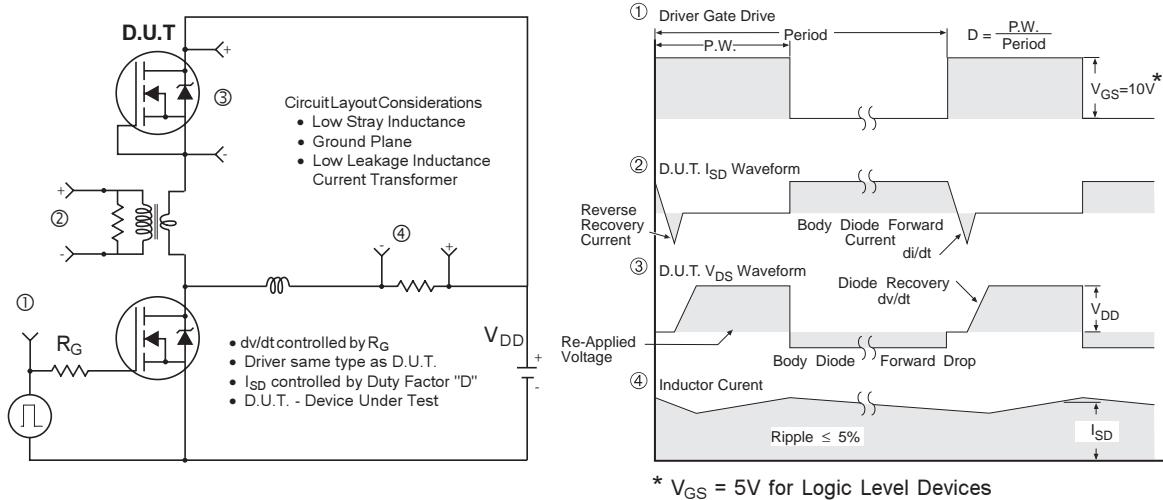


Fig 30. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

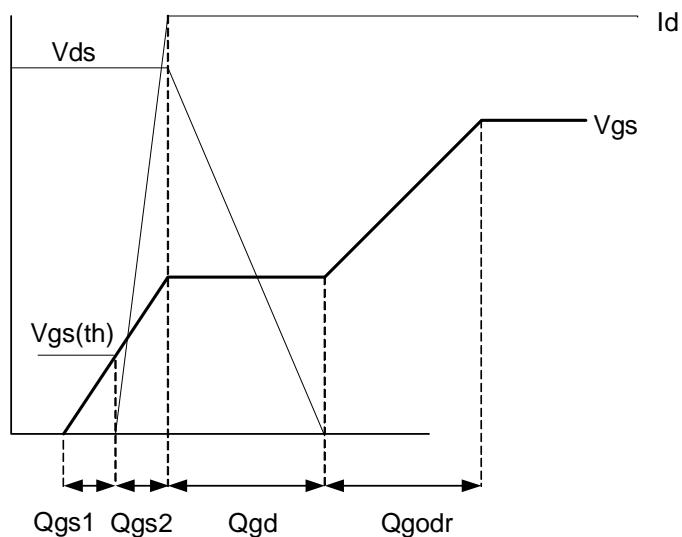
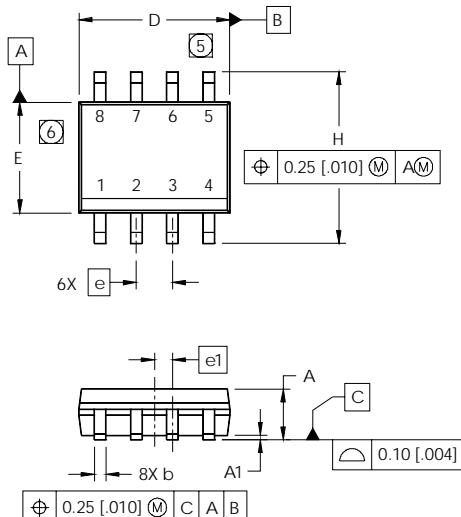


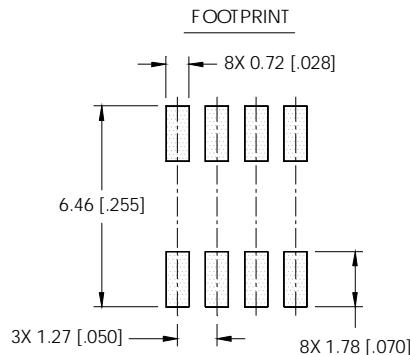
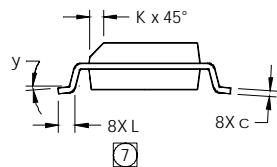
Fig 31. Gate Charge Waveform

SO-8 Package Outline

Dimensions are shown in millimeters (inches)

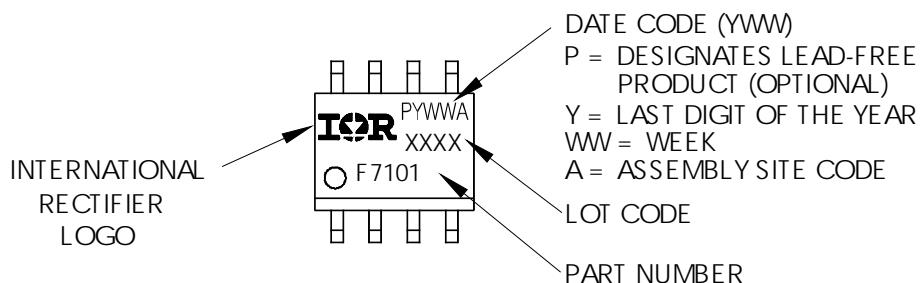


DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.0532	.0688	1.35	1.75
A1	.0040	.0098	0.10	0.25
b	.013	.020	0.33	0.51
c	.0075	.0098	0.19	0.25
D	.189	.1968	4.80	5.00
E	.1497	.1574	3.80	4.00
e1	.050	BASIC	1.27	BASIC
e1	.025	BASIC	0.635	BASIC
H	.2284	.2440	5.80	6.20
K	.0099	.0196	0.25	0.50
L	.016	.050	0.40	1.27
y	0°	8°	0°	8°



SO-8 Part Marking

EXAMPLE: THIS IS AN IRF7101 (MOSFET)

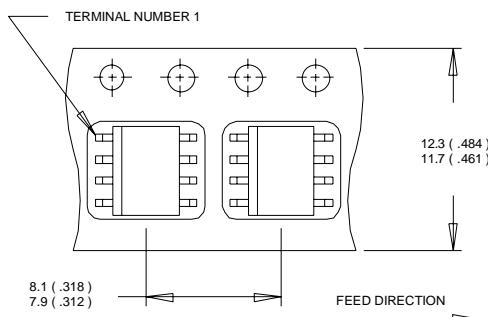


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SO-8 Tape and Reel

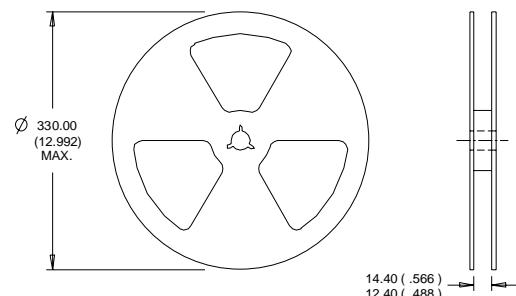
Dimensions are shown in millimeters (inches)

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NOTES:

1. CONTROLLING DIMENSION : MILLIMETER.
2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS(INCHES).
3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES :

1. CONTROLLING DIMENSION : MILLIMETER.
2. OUTLINE CONFORMS TO EIA-481 & EIA-541.

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Starting $T_J = 25^\circ\text{C}$, Q1: $L = 0.95\text{mH}$
 $R_G = 25\Omega$, $I_{AS} = 8.3\text{A}$; Q2: $L = 0.54\text{mH}$
 $R_G = 25\Omega$, $I_{AS} = 9.8\text{A}$.
- ③ Pulse width $\leq 400\mu\text{s}$; duty cycle $\leq 2\%$.
- ④ When mounted on 1 inch square copper board.
- ⑤ R_θ is measured at T_J approximately 90°C .

Data and specifications subject to change without notice.
This product has been designed and qualified for the Consumer market.
Qualifications Standards can be found on IR's Web site.

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